

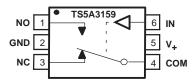
#### **Description**

The TS5A3159 is a single-pole double-throw (SPDT) analog switch that is designed to operate from 1.65 V to 5.5 V. The device offers a low ON-state resistance and an excellent ON-resistance, matching with the break-before-make feature to prevent signal distortion during the transferring of a signal from one channel to another. The device has an excellent total harmonic distortion (THD) performance and consumes very low power. These features make this device suitable for portable audio applications.

#### **Applications**

- Cell Phones
- PDAs
- Portable Instrumentation

#### SOT-23 OR SC-70 PACKAGE (TOP VIEW)



#### **FUNCTION TABLE**

IN	NC TO COM, COM TO NC	NO TO COM, COM TO NO
L	ON	OFF
Н	OFF	ON

#### **Features**

- Specified Break-Before-Make Switching
- Low ON-State Resistance (1 Ω)
- Control Inputs Are 5-V Tolerant
- Low Charge Injection
- Excellent ON-Resistance Matching
- Low Total Harmonic Distortion
- 1.65-V to 5.5-V Single-Supply Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)

#### **Summary of Characteristics**

 $V_{+} = 5 \text{ V} \text{ and } T_{A} = 25 \,^{\circ}\text{C}$ 

, ,,	
Configuration	2:1 Multiplexer/ Demultiplexer (1 × SPDT)
Number of channels	1
ON-state resistance (ron)	1.1 Ω
ON-state resistance match (Δr <sub>on</sub> )	0.1 Ω
ON-state resistance flatness (ron(flat))	0.15 Ω
Turn on/turn off time (ton/toff)	20 ns/15 ns
Break-before-make time (t <sub>BBM</sub> )	12 ns
Charge injection (Q <sub>C</sub> )	36 pC
Bandwidth (BW)	100 MHz
OFF isolation (OISO)	-65 dB at 1 MHz
Crosstalk (X <sub>TALK</sub> )	-65 dB at 1 MHz
Total harmonic distortion (THD)	0.01%
Leakage current (INO(OFF)/INC(OFF))	±20 nA
Package option	6-pin DBV or DCK



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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#### ORDERING INFORMATION

TA	PACKAGE <sup>(1)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING(2)
4000 1- 0500	SOT (SOT-23) – DBV	Tape and reel	TS5A3159DBVR	JA8_
-40°C to 85°C	SOT (SC-70) – DCK <sup>(2)</sup>	Tape and reel	TS5A3159DCKR	JA_

<sup>(1)</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package. (2) DBV/DCK: The actual top-side marking has one additional character that designates the assembly/test site.

### Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
٧+	Supply voltage range(2)		-0.5	6.5	V
V <sub>NO</sub> , V <sub>COM</sub>	Analog voltage range(2)(3)(4)		-0.5	$V_{+} + 0.5$	V
II/OK	Analog port diode current	$V_{NO}$ , $V_{COM} < 0$ or $V_{NO}$ , $V_{COM} > V_{+}$		±50	mA
INO, ICOM	ON-state switch current	$V_{NO}$ , $V_{COM} = 0$ to $V_{+}$		±200	mA
	ON-state peak switch current(5)			±400	mA
VIN	Digital input voltage range(2)(3)		-0.5	6.5	V
lıK	Digital input clamp current	V <sub>IN</sub> < 0		-50	mA
	Continuous current through V+ or GND			±100	mA
θЈА	Package thermal impedance(6)			165	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>(2)</sup> All voltages are with respect to ground, unless otherwise specified.

<sup>(3)</sup> The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

<sup>(4)</sup> This value is limited to 5.5 V maximum.

<sup>(5)</sup> Pulse at 1 ms duration < 10% duty cycle.

<sup>(6)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.





# Electrical Characteristics for 5-V Supply $V_+ = 4.5 \text{ V}$ to 5.5 V and $T_A = -40 ^{\circ}\text{C}$ to $85 ^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITION	NS	TA	V <sub>+</sub>	MIN	TYP(1)	MAX	UNIT
Analog Switch									
Analog signal range	VCOM, VNO,VNC					0		٧+	V
Peak ON resistance		$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,	Switch ON,	25°C	4.5 V		1	1.5	Ω
reak ON resistance	<sup>r</sup> peak	$I_{COM} = -30 \text{ mA},$	See Figure 11	Full	4.5 V			1.5	52
ON-state resistance	r	$V_{NO}$ or $V_{NC} = 2.5 \text{ V}$ ,	Switch ON,	25°C	4.5 V		0.75	1.1	Ω
ON-State resistance	ron	$I_{COM} = -30 \text{ mA},$	See Figure 11	Full	4.5 V			1.1	52
ON-state resistance match between channels	Δr <sub>on</sub>	$V_{NO}$ or $V_{NC} = 2.5 \text{ V}$ , $I_{COM} = -30 \text{ mA}$ ,	Switch ON, See Figure 11	25°C	4.5 V		0.1		Ω
ON-state resistance		$0 \le V_{NO}$ or $V_{NC} \le V_+$ , $I_{COM} = -30$ mA,	Switch ON,	25°C	4.5 V		0.233		
flatness	ron(flat)	$V_{NO}$ or $V_{NC} = 1 \text{ V}$ , 1.5 V, 2.5 V, $I_{COM} = -30 \text{ mA}$ ,	See Figure 11	25°C	4.5 V		0.15		Ω
NC, NO	INC(OFF),	$V_{NC}$ or $V_{NO} = 4.5 \text{ V}$ ,	Switch OFF,	25°C	5.5 V	-2	0.2	2	nA
OFF leakage current	I <sub>NO</sub> (OFF)	$V_{COM} = 0$ ,	See Figure 12	Full	5.5 V	-20		20	nA
NC, NO	INC(ON),	$V_{NC}$ or $V_{NO} = 4.5 V$ ,	Switch ON,	25°C	5.5 V	-4	2.8	4	nA
ON leakage current	INO(ON)	V <sub>COM</sub> = Open,	See Figure 13	Full	5.5 V	-40		40	IIA
COM	loor worn	$V_{NC}$ or $V_{NO} = 4.5 \text{ V}$ or Open,	Switch ON,	25°C	5.5 V	-4	0.47	4	nA
ON leakage current	ICOM(ON)	$V_{COM} = 4.5 V$	See Figure 13	Full	3.5 V	-40		40	IIA
Digital Inputs (IN)									
Input logic high	VIH			Full		2.4		5.5	V
Input logic low	V <sub>IL</sub>			Full		0		0.8	V
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>IN</sub> = 5.5 V or 0		Full	5.5 V	-1		1	μΑ

 $<sup>(1)</sup> T_A = 25^{\circ}C$ 



#### **Electrical Characteristics for 5-V Supply (continued)**

 $V_{+} = 4.5 \; \text{V}$  to 5.5 V and  $T_{\mbox{\scriptsize A}} = -40 ^{\circ} \mbox{\scriptsize C}$  to  $85 ^{\circ} \mbox{\scriptsize C}$  (unless otherwise noted)

PARAMETER	SYMBOL	TEST COND	DITIONS	TA	V <sub>+</sub>	MIN	TYP(1)	MAX	UNIT
Dynamic	•			•					
Turn-on time	tON	$V_{COM} = V_+,$	C <sub>L</sub> = 35 pF,	25°C	4.5 V to		20	35	ns
Turr on time	'ON	$R_L = 50 \Omega$	See Figure 15	Full	5.5 V			40	113
Turn-off time	tOFF	$V_{COM} = V_+,$	$C_L = 35 \text{ pF},$	25°C	4.5 V to		15	20	ns
	JOH	$R_L = 50 \Omega$ ,	See Figure 15	Full	5.5 V			35	
Break-before-make	t <sub>BBM</sub>	$V_{NC} = V_{NO} = V_{+}/2$	$C_L = 35 \text{ pF},$	25°C	4.5 V to	1	12	14.5	ns
time	NIGGE	$R_L = 50 \Omega$ ,	See Figure 16	Full	5.5 V	1			
Charge injection	QC	$C_L = 1 \text{ nF, } V_{GEN} = 0 \text{ V,}$	See Figure 20	25°C	5 V		36		рC
NC, NO OFF capacitance	C <sub>NC(OFF)</sub> , C <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	5 V		23		pF
NC, NO ON capacitance	C <sub>NC(ON)</sub> , C <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	5 V		84		pF
COM ON capacitance	CCOM(ON)	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	5 V		84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+} \text{ or GND},$	See Figure 14	25°C	5 V		2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	5 V		100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	5 V		-65		dB
Crosstalk	XTALK	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	5 V		-65		dB
Total harmonic distortion	THD	$R_L = 600 \Omega$ , $C_L = 50 pF$ ,	f = 600 Hz to 20 kHz, See Figure 21	25°C	5 V		0.01		%
Supply	•			•					
Positive supply current	l <sub>+</sub>	$V_{IN} = V_{+}$ or GND,	Switch ON or OFF	Full	5.5 V			0.1	μΑ

 $<sup>(1)</sup> T_A = 25^{\circ}C$ 





# Electrical Characteristics for 3.3-V Supply $V_+ = 3 \text{ V to } 3.6 \text{ V and } T_A = -40^{\circ}\text{C} \text{ to } 85^{\circ}\text{C} \text{ (unless otherwise noted)}$

PARAMETER	SYMBOL	TEST CONDITION	ONS	TA	V <sub>+</sub>	MIN	TYP(1)	MAX	UNIT
Analog Switch									
Analog signal range	V <sub>COM</sub> , V <sub>NO</sub> , V <sub>NC</sub>					0		V <sub>+</sub>	V
Peak		$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,	Switch ON,	25°C	3 V		1.35	2.1	0
ON-state resistance	<sup>r</sup> peak	$I_{COM} = -24 \text{ mA},$	See Figure 11	Full	3 V			2.1	Ω
ON-state resistance	,	$V_{NO}$ or $V_{NC} = 2 V$ ,	Switch ON,	25°C	3 V		1.15	1.5	Ω
OIV-State resistance	r <sub>on</sub>	$I_{COM} = -24 \text{ mA},$	See Figure 11	Full	3 V			1.5	52
ON-state resistance match between channels	Δr <sub>on</sub>	$V_{NO}$ or $V_{NC} = 2 \text{ V}$ , 0.8 V, $I_{COM} = -24 \text{ mA}$ ,	Switch ON, See Figure 11	25°C	3 V		0.11		Ω
ON-state resistance		$0 \le V_{NO}$ or $V_{NC} \le V_+$ , $I_{COM} = -24$ mA,	Switch ON,	25°C	3 V		0.225		0
flatness	ron(flat)	$V_{NO}$ or $V_{NC} = 2 \text{ V}$ , 0.8 V, $I_{COM} = -24 \text{ mA}$ ,	See Figure 11	25°C	3 V	0.25			Ω
NC, NO OFF leakage current	INC(OFF), INO(OFF)	$V_{NC}$ or $V_{NO} = 3 V$ , $V_{COM} = 0$ ,	Switch OFF, See Figure 12	25°C	3.6 V		0.2		nA
NC, NO ON leakage current	INC(ON), INO(ON)	$V_{NC}$ or $V_{NO} = 3 V$ , $V_{COM} = Open$ ,	Switch ON, See Figure 13	25°C	3.6 V		2.8		nA
COM ON leakage current	ICOM(ON)	$V_{NC}$ or $V_{NO} = 3 \text{ V or Open}$ , $V_{COM} = 3 \text{ V}$ ,	Switch ON, See Figure 13	25°C	3.6 V		0.47		nA
Digital Inputs (IN)				•					
Input logic high	VIH			Full		2		5.5	V
Input logic low	V <sub>IL</sub>			Full		0	0.6	3	V
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>IN</sub> = 5.5 V or 0		Full	3.6 V	-1		1	μΑ

 $<sup>(1)</sup> T_A = 25^{\circ}C$ 



# Electrical Characteristics for 3.3-V Supply (continued) (V<sub>+</sub> = 3 V to 3.6 V and $T_A$ = -40 °C to 85 °C) (unless otherwise noted)

PARAMETER	SYMBOL	TEST COND	DITIONS	TA	٧+	MIN	TYP(1)	MAX	UNIT
Dynamic									
Turn-on time	toN	$V_{COM} = V_+,$ $R_L = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 15	25°C Full	3 V to 3.6 V		30	40 55	ns
Turn-off time	tOFF	V <sub>COM</sub> = V <sub>+</sub> , R <sub>L</sub> = 50 Ω,	C <sub>L</sub> = 35 pF, See Figure 15	25°C Full	3 V to 3.6 V		20	25 40	ns
Break-before-make time	<sup>t</sup> BBM	$V_{NC} = V_{NO} = V_{+}/2,$ $R_{L} = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 16	25°C Full	3 V to 3.6 V	1	21	29	ns
Charge injection	QC	C <sub>L</sub> = 1 nF, V <sub>GEN</sub> = 0 V,	See Figure 20	25°C	3.3 V		20		рС
NC, NO OFF capacitance	C <sub>NC(OFF)</sub> , C <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	3.3 V		23		pF
NC, NO ON capacitance	C <sub>NC(ON)</sub> , C <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	3.3V		84		pF
COM ON capacitance	C <sub>COM</sub> (ON)	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	3.3 V		84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	3.3 V		2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	3.3 V		100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	3.3 V		-65		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	3.3 V		-65		dB
Total harmonic distortion	THD	$R_L = 600 \Omega,$ $C_L = 50 pF,$	f = 600 Hz to 20 kHz, See Figure 21	25°C	3.3 V		0.015		%
Supply	1								
Positive supply current	l <sub>+</sub>	$V_{IN} = V_{+} \text{ or GND},$	Switch ON or OFF	Full	3.6 V			0.1	μΑ

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 





Electrical Characteristics for 2.5-V Supply  $V_+=2.3$  V to 2.7 V and  $T_A=-40^{\circ}C$  to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIO	NS	TA	V <sub>+</sub>	MIN	TYP(1)	MAX	UNIT
Analog Switch									
Analog signal range	V <sub>COM</sub> , V <sub>NO</sub> ,V <sub>NC</sub>					0		٧+	V
Peak ON-state resistance	rpeak	$0 \le V_{NO}$ or $V_{NC} \le V_+$ , $I_{COM} = -8 \text{ mA}$ ,	Switch ON, See Figure 11	25°C Full	2.5 V		1.7	2.7	Ω
		$V_{NO}$ or $V_{NC} = 1.8 \text{ V}$ ,	Switch ON.	25°C			1.45	2	
ON-state resistance	ron	$I_{COM} = -8 \text{ mA},$	See Figure 11	Full	2.5 V			2	Ω
ON-state resistance match between channels	Δr <sub>on</sub>	$V_{NO}$ or $V_{NC} = 0.8 \text{ V}$ , 1.8 V, $I_{COM} = -8 \text{ mA}$ ,	Switch ON, See Figure 11	25°C	2.5 V		0.7		Ω
ON-state resistance		$0 \le V_{NO}$ or $V_{NC} \le V_+$ , $I_{COM} = -8 \text{ mA}$ ,	Switch ON,	25°C	2.5 V		0.5		0
flatness	ron(flat)	$V_{NO}$ or $V_{NC} = 0.8 \text{ V}$ , 1.8 V, $I_{COM} = -8 \text{ mA}$ ,	See Figure 11	25°C	2.5 V	0.45			Ω
NC, NO Off leakage current	INC(OFF), INO(OFF)	$V_{NC}$ or $V_{NO} = 2.3 \text{ V}$ , $V_{COM} = 0$ ,	Switch OFF, See Figure 12	25°C	2.7 V		0.2		nA
NC, NO On leakage current	INC(ON), INO(ON)	$V_{NC}$ or $V_{NO} = 2.3 \text{ V}$ , $V_{COM} = \text{Open}$ ,	Switch ON, See Figure 13	25°C	2.7 V		2.8		nA
COM On leakage current	ICOM(ON)	V <sub>NC</sub> or V <sub>NO</sub> = 2.3 V or Open, V <sub>COM</sub> = 2.3 V,	Switch ON, See Figure 13	25°C	2.7 V		0.47		nA
Digital Inputs (IN)									
Input logic high	VIH		-	Full		1.8	•	5.5	V
Input logic low	V <sub>IL</sub>			Full		0	0.6	6	V
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	$V_{IN} = 5.5 \text{ V or } 0$		Full	2.7 V	-1		1	μΑ

 $<sup>(1)</sup> T_A = 25^{\circ}C$ 

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# Electrical Characteristics for 2.5-V Supply (continued) $V_+ = 2.3 \text{ V}$ to 2.7 V and $T_A = -40 ^{\circ}\text{C}$ to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST COND	DITIONS	TA	V <sub>+</sub>	MIN	TYP(1)	MAX	UNIT
Dynamic									
Turn-on time	tON	$V_{COM} = V_+,$ $R_1 = 50 \Omega,$	C <sub>L</sub> = 35 pF, See Figure 15	25°C Full	2.3 V to 2.7 V		40	55 70	ns
Turn-off time	tOFF	V <sub>COM</sub> = V <sub>+</sub> ,	C <sub>L</sub> = 35 pF,	25°C	2.3 V to		30	40	ns
	·OFF	$R_L = 50 \Omega$ ,	See Figure 15	Full	2.7 V			55	
Break-before-make time	<sup>t</sup> BBM	$V_{NC} = V_{NO} = V_{+}/2$ , $R_{L} = 50 \Omega$ ,	C <sub>L</sub> = 35 pF, See Figure 16	25°C Full	2.3 V to 2.7 V	1	33	39	ns
Charge injection	QC	C <sub>L</sub> = 1 nF, V <sub>GEN</sub> = 0 V,	See Figure 20	25°C	2.5 V		13		рС
NC, NO OFF capacitance	C <sub>NC(OFF)</sub> , C <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	2.5 V		23		pF
NC, NO ON capacitance	C <sub>NC(ON)</sub> , C <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	2.5V		84		pF
COM ON capacitance	C <sub>COM</sub> (ON)	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	2.5 V		84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	2.5 V		2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	2.5 V		100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	2.5 V		-64		dB
Crosstalk	X <sub>TALK</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	2.5 V		-64		dB
Total harmonic distortion	THD	$R_L = 600 \Omega,$ $C_L = 50 pF,$	f = 600 Hz to 20 kHz, See Figure 21	25°C	2.5 V		0.025		%
Supply									
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+} \text{ or GND},$	Switch ON or OFF	Full	2.7 V			0.1	μА

 $<sup>(1)</sup> T_A = 25^{\circ}C$ 





Electrical Characteristics for 1.8-V Supply  $V_+=1.65~V$  to 1.95 V and  $T_A=-40^{\circ}C$  to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIO	NS	TA	٧+	MIN	TYP(1)	MAX	UNIT	
Analog Switch										
Analog signal range	V <sub>COM</sub> , V <sub>NO</sub> ,V <sub>NC</sub>					0		٧+	٧	
Peak		$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,	Switch ON,	25°C	1.8 V		4	4.9	Ω	
ON-state resistance	<sup>r</sup> peak	$I_{COM} = -2 \text{ mA},$	See Figure 11	Full	1.0 V			4.9	22	
ON-state resistance	r	$V_{NO}$ or $V_{NC} = 1.5 V$ ,	Switch ON,	25°C	1.8 V		1.7	3.2	Ω	
ON-State resistance	ron	$I_{COM} = -2 \text{ mA},$	See Figure 11	Full	1.0 V			3.2	22	
ON-state resistance match between	A ==	$V_{NO}$ or $V_{NC} = 0.6 \text{ V}$ , 1.5 V,	Switch ON,	25°C	1.8 V		0.7		Ω	
channels	∆r <sub>on</sub>	$I_{COM} = -2 \text{ mA},$	See Figure 11	Full	1.0 V		0.7		22	
		$0 \le V_{NO}$ or $V_{NC} \le V_+$ ,		25°C			1.85			
ON-state resistance		$I_{COM} = -2 \text{ mA},$	Switch ON,	Full	1.8 V		1.85			
flatness	ron(flat)	$V_{NO}$ or $V_{NC} = 0.6 \text{ V}$ , 1.5 V,	See Figure 11	25°C	1.0 V		0.9		Ω	
		$I_{COM} = -2 \text{ mA},$		Full		0.9				
NC, NO Off leakage current	INC(OFF), INO(OFF)	$V_{NC}$ or $V_{NO} = 1.65 V$ , $V_{COM} = 0$ ,	Switch OFF, See Figure 12	25°C	1.95 V		0.2		nA	
NC, NO On leakage current	INC(ON), INO(ON)	$V_{NC}$ or $V_{NO} = 1.65 V$ , $V_{COM} = Open$ ,	Switch ON, See Figure 13	25°C	1.95 V		2.8		nA	
COM On leakage current	ICOM(ON)	$V_{NC}$ or $V_{NO} = 1.65$ V or Open, $V_{COM} = 1.65$ V,	Switch ON, See Figure 13	25°C	1.95 V		0.47		nA	
Digital Inputs (IN)										
Input logic high	VIH			Full		1.5		5.5	V	
Input logic low	V <sub>IL</sub>			Full		0	0.6	3	V	
Input leakage current	I <sub>IH</sub> , I <sub>IL</sub>	V <sub>IN</sub> = 5.5 V or 0		Full	1.95 V	-1		1	μΑ	

<sup>(1)</sup>  $T_A = 25^{\circ}C$ 

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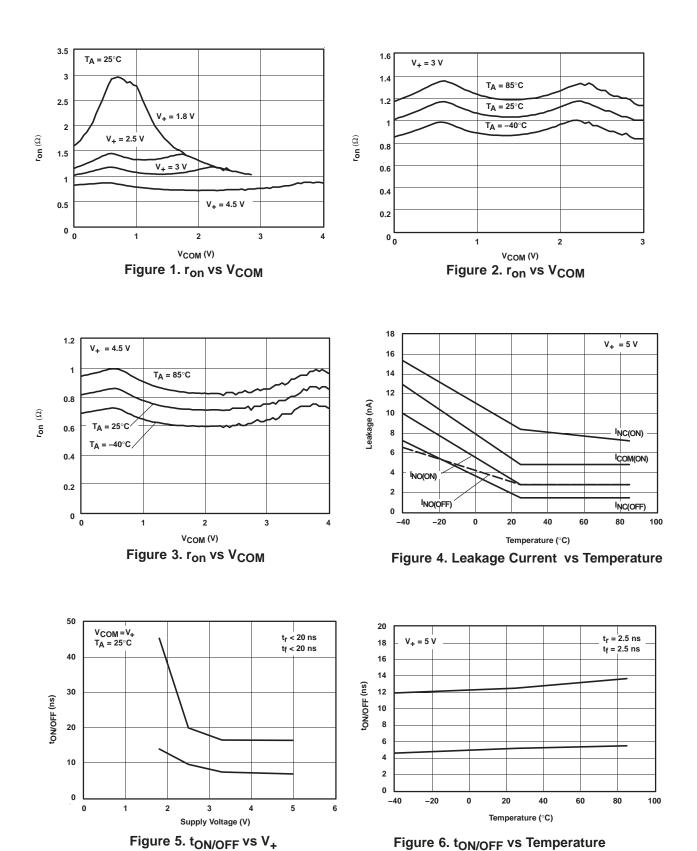
Electrical Characteristics for 1.8-V Supply (continued)  $V_+ = 1.65 \ V$  to 1.95 V and  $T_A = -40 \ C$  to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDIT	ONS	TA	٧+	MIN	TYP(1)	MAX	UNIT
Dynamic									
Turn-on time	4	$V_{COM} = V_+,$	$C_L = 35 pF$ ,	25°C	1.65 V to		65	70	20
Turn-orr time	tON	$R_L = 50 \Omega$ ,	See Figure 15	Full	1.95 V			95	ns
Turn-off time	torr	$V_{COM} = V_+,$	$C_L = 35 pF$ ,	25°C	1.65 V to		40	55	ns
Tarri on time	tOFF	$R_L = 50 \Omega$	See Figure 15	Full	1.95 V			70	113
Break-before-make	topu	$V_{NC} = V_{NO} = V_{+}/2,$	$C_L = 35 pF$ ,	25°C	1.65 V to	1	60	72	ns
time	<sup>†</sup> BBM	$R_L = 50 \Omega$	See Figure 16	Full	1.95 V	0.5			113
Charge injection	QC	$C_L = 1 \text{ nF, } V_{GEN} = 0 \text{ V,}$	See Figure 20	25°C	1.8 V		13		рС
NC, NO OFF capacitance	C <sub>NC(OFF)</sub> , C <sub>NO(OFF)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch OFF,	See Figure 14	25°C	1.8 V		23		pF
NC, NO ON capacitance	C <sub>NC(ON)</sub> , C <sub>NO(ON)</sub>	$V_{NC}$ or $V_{NO} = V_{+}$ or GND, Switch ON,	See Figure 14	25°C	1.8V		84		pF
COM ON capacitance	CCOM(ON)	V <sub>COM</sub> = V <sub>+</sub> or GND, Switch ON,	See Figure 14	25°C	1.8 V		84		pF
Digital input capacitance	C <sub>IN</sub>	$V_{IN} = V_{+}$ or GND,	See Figure 14	25°C	1.8 V		2.1		pF
Bandwidth	BW	$R_L = 50 \Omega$ , Switch ON,	See Figure 17	25°C	1.8 V		100		MHz
OFF isolation	O <sub>ISO</sub>	$R_L = 50 \Omega$ , f = 1 MHz,	Switch OFF, See Figure 18	25°C	1.8 V		-63		dB
Crosstalk	XTALK	$R_L = 50 \Omega$ , f = 1 MHz,	Switch ON, See Figure 19	25°C	1.8 V		-63		dB
Supply									
Positive supply current	I <sub>+</sub>	$V_{IN} = V_{+}$ or GND,	Switch ON or OFF	Full	1.95 V			0.1	μА

 $<sup>(1)</sup> T_A = 25^{\circ}C$ 



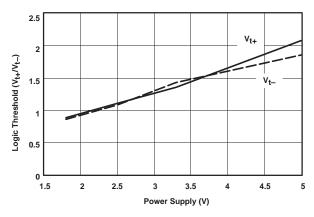
#### TYPICAL PERFORMANCE



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Figure 6. t<sub>ON/OFF</sub> vs Temperature





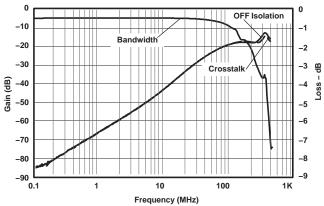
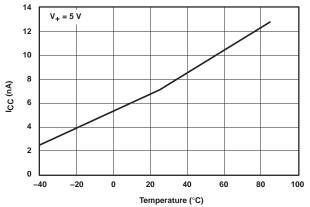


Figure 7. Logic Threshold vs Power Supply

Figure 8. Frequency Response



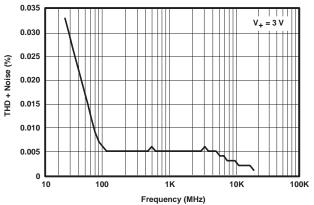


Figure 9. Power-Supply Current vs Temperature

Figure 10. Total Harmonic Distortion (THD) vs Frequency





#### **PIN DESCRIPTION**

PIN NUMBER	NAME	DESCRIPTION					
1	NO	Normally-open terminal					
2	GND	Digital ground					
3	NC	Normally-closed terminal					
4	COM	Common terminal					
5	V <sub>+</sub>	Power supply					
6	IN	Digital control pin to connect COM terminal to NO or NC terminals					

#### PARAMETER DESCRIPTION

SYMBOL	DESCRIPTION
VCOM	Voltage at COM
VNC	Voltage at NC
V <sub>NO</sub>	Voltage at NO
r <sub>on</sub>	Resistance between COM and NC or COM and NO ports, when the channel is ON
rpeak	Peak ON-state resistance over a specified voltage range
$\Delta r_{\sf on}$	Difference of r <sub>on</sub> between channels
ron(flat)	Difference between the maximum and minimum value of ron in a channel over the specified range of conditions
INC(OFF)	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the OFF state under worst-case input and output conditions
I <sub>NO(OFF)</sub>	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the OFF state under worst-case input and output conditions
INC(ON)	Leakage current measured at the NC port, with the corresponding channel (NC to COM) in the ON state and the output (COM) being open
I <sub>NO(ON)</sub>	Leakage current measured at the NO port, with the corresponding channel (NO to COM) in the ON state and the output (COM) being open
ICOM(ON)	Leakage current measured at the COM port, with the corresponding channel (COM to NO or COM to NC) in the ON state and the output (NC or NO) being open
V <sub>IH</sub>	Minimum input voltage for logic high for the control input (IN)
V <sub>IL</sub>	Minimum input voltage for logic low for the control input (IN)
VIN	Voltage at IN
I <sub>IH</sub> , I <sub>IL</sub>	Leakage current measured at IN
tON	Turn-on time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog outputs (COM, NC, or NO) signal, when the switch is turning ON.
tOFF	Turn-off time for the switch. This parameter is measured under the specified range of conditions and by the propagation delay between the digital control (IN) signal and analog outputs (COM, NC, or NO) signal, when the switch is turning OFF.
tBBM	Break-before-make time. This parameter is measured under the specified range of conditions and by the propagation delay between the output of two adjacent analog channels (NC and NO), when the control signal changes state.
QC	Charge injection is a measurement of unwanted signal coupling from the control (IN) input to the analog (NC, NO, or COM) output. This is measured in coulomb (C) and measured by the total charge induced due to switching of the control input. Charge injection, $Q_C = C_L \times \Delta V_O$ , $C_L$ is the load capacitance, and $\Delta V_O$ is the change in analog output voltage.

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#### **PARAMETER DESCRIPTION (continued)**

SYMBOL	DESCRIPTION
C <sub>NC(OFF)</sub>	Capacitance at the NC port when the corresponding channel (NC to COM) is OFF
C <sub>NO(OFF)</sub>	Capacitance at the NO port when the corresponding channel (NO to COM) is OFF
C <sub>NC(ON)</sub>	Capacitance at the NC port when the corresponding channel (NC to COM) is ON
C <sub>NO(ON)</sub>	Capacitance at the NO port when the corresponding channel (NO to COM) is ON
C <sub>COM(ON)</sub>	Capacitance at the COM port when the corresponding channel (COM to NC or COM to NO) is ON
C <sub>IN</sub>	Capacitance of IN
O <sub>ISO</sub>	OFF isolation of the switch is a measurement OFF-state switch impedance. This is measured in dB in a specific frequency, with the corresponding channel (NC to COM or NO to COM) in the OFF state.
X <sub>TALK</sub>	Crosstalk is a measurement of unwanted signal coupling from an ON channel to an OFF channel (NC to NO or NO to NC). This is measured in a specific frequency and in dB.
BW	Bandwidth of the switch. This is the frequency in which the gain of an ON channel is -3 dB below the DC gain.
I <sub>+</sub>	Static power-supply current with the control (IN) pin at V <sub>+</sub> or GND
$\Delta l_{+}$	This is the increase in $I_+$ for each control (IN) input that is at the specified voltage, rather than at $V_+$ or GND.



#### PARAMETER MEASUREMENT INFORMATION

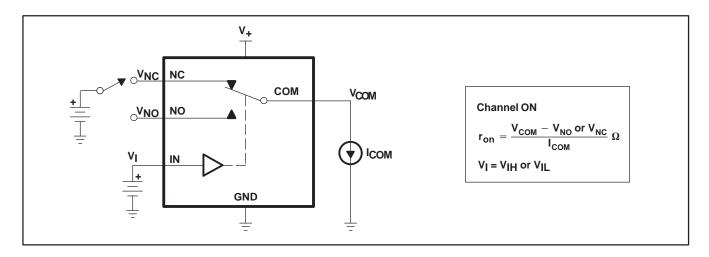


Figure 11. ON-State Resistance (ron)

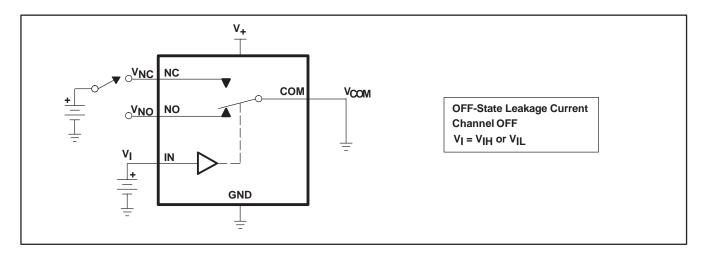


Figure 12. OFF-State Leakage Current ( $I_{NC(OFF)}$ ,  $I_{NO(OFF)}$ )

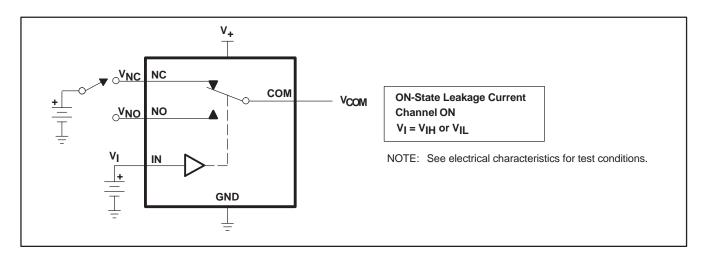


Figure 13. ON-State Leakage Current ( $I_{COM(ON)}$ ,  $I_{NC(ON)}$ ,  $I_{NO(ON)}$ )



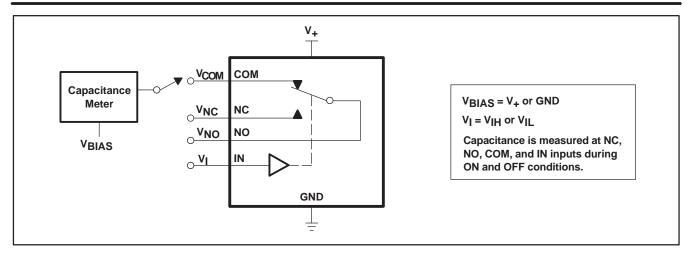
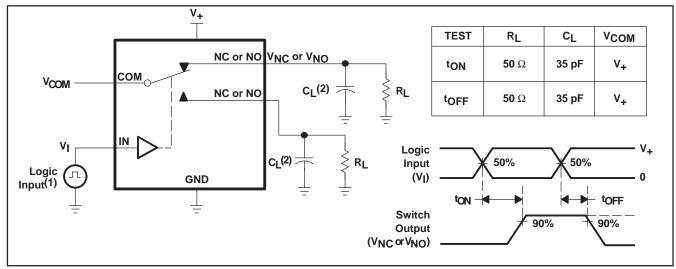
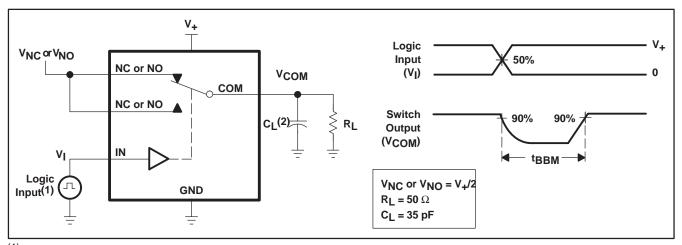


Figure 14. Capacitance (C<sub>I</sub>, C<sub>COM(ON)</sub>, C<sub>NC(OFF)</sub>, C<sub>NO(OFF)</sub>, C<sub>NC(ON)</sub>, C<sub>NO(ON)</sub>)



- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub> < 5 ns.
- (2) C<sub>L</sub> includes probe and jig capacitance.

Figure 15. Turn-On (t<sub>ON</sub>) and Turn-Off Time (t<sub>OFF</sub>)



- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f < 5 \text{ ns}$ ,  $t_f < 5 \text{ ns}$ .
- (2) C<sub>I</sub> includes probe and jig capacitance.

Figure 16. Break-Before-Make Time (t<sub>BBM</sub>)



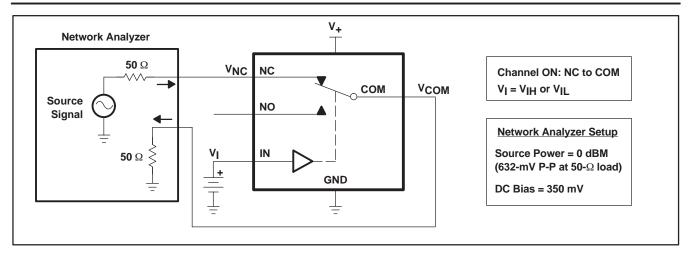


Figure 17. Bandwidth (BW)

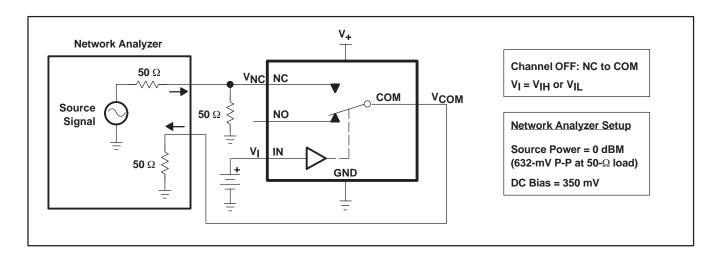


Figure 18. OFF Isolation (O<sub>ISO</sub>)

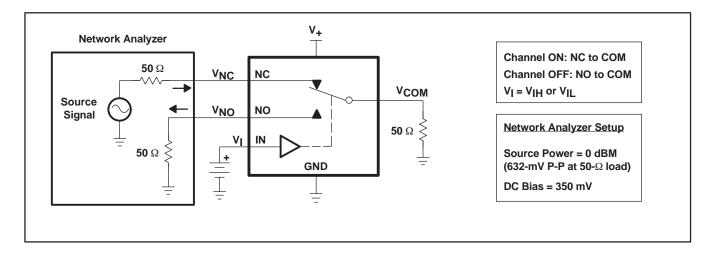
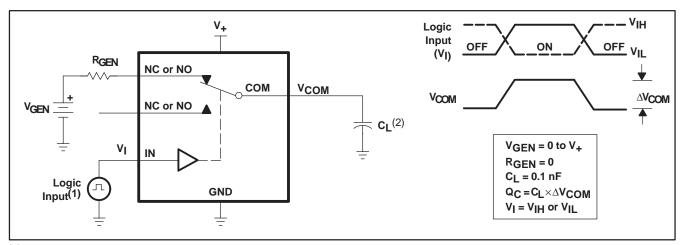


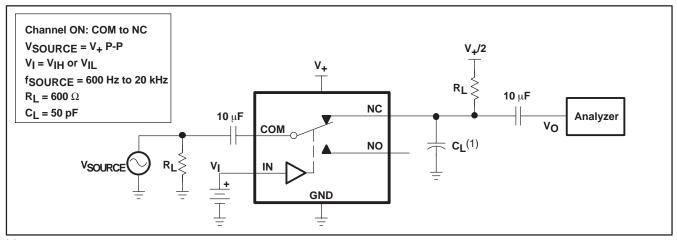
Figure 19. Crosstalk (X<sub>TALK</sub>)





- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_f$  < 5 ns.
- (2)  $C_L$  includes probe and jig capacitance.

Figure 20. Charge Injection (Q<sub>C</sub>)



(1)  $C_L$  includes probe and jig capacitance.

Figure 21. Total Harmonic Distortion (THD)





11-Apr-2013

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
TS5A3159DBVR	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JA8K ~ JA8R)	Samples
TS5A3159DBVRE4	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JA8K ~ JA8R)	Samples
TS5A3159DBVRG4	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JA8K ~ JA8R)	Samples
TS5A3159DBVT	ACTIVE	SOT-23	DBV	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JA8K ~ JA8R)	Samples
TS5A3159DBVTE4	ACTIVE	SOT-23	DBV	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JA8K ~ JA8R)	Samples
TS5A3159DBVTG4	ACTIVE	SOT-23	DBV	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JA8K ~ JA8R)	Samples
TS5A3159DCKR	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JAK ~ JAR ~ JAZ)	Samples
TS5A3159DCKRE4	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JAK ~ JAR ~ JAZ)	Samples
TS5A3159DCKRG4	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JAK ~ JAR ~ JAZ)	Samples
TS5A3159DCKT	ACTIVE	SC70	DCK	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JAK ~ JAR ~ JAZ)	Samples
TS5A3159DCKTE4	ACTIVE	SC70	DCK	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JAK ~ JAR ~ JAZ)	Samples
TS5A3159DCKTG4	ACTIVE	SC70	DCK	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(JAK ~ JAR ~ JAZ)	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



#### PACKAGE OPTION ADDENDUM

11-Apr-2013

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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#### OTHER QUALIFIED VERSIONS OF TS5A3159:

Automotive: TS5A3159-Q1

■ Enhanced Product: TS5A3159-EP

NOTE: Qualified Version Definitions:

- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications

### PACKAGE MATERIALS INFORMATION

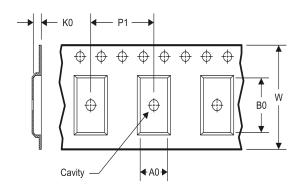
www.ti.com 30-Jul-2012

#### TAPE AND REEL INFORMATION

#### **REEL DIMENSIONS**







A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### TAPE AND REEL INFORMATION

#### \*All dimensions are nominal

All differsions are norminal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS5A3159DBVR	SOT-23	DBV	6	3000	180.0	9.2	3.17	3.23	1.37	4.0	8.0	Q3
TS5A3159DBVT	SOT-23	DBV	6	250	180.0	9.2	3.17	3.23	1.37	4.0	8.0	Q3
TS5A3159DCKR	SC70	DCK	6	3000	180.0	9.2	2.3	2.55	1.2	4.0	8.0	Q3
TS5A3159DCKT	SC70	DCK	6	250	180.0	9.2	2.3	2.55	1.2	4.0	8.0	Q3

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\*All dimensions are nominal

Device	Device Package Type		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS5A3159DBVR	SOT-23	DBV	6	3000	205.0	200.0	33.0
TS5A3159DBVT	SOT-23	DBV	6	250	205.0	200.0	33.0
TS5A3159DCKR	SC70	DCK	6	3000	205.0	200.0	33.0
TS5A3159DCKT	SC70	DCK	6	250	205.0	200.0	33.0

## DBV (R-PDSO-G6)

#### PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- Falls within JEDEC MO-178 Variation AB, except minimum lead width.



## DBV (R-PDSO-G6)

### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



## DCK (R-PDSO-G6)

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AB.



## DCK (R-PDSO-G6)

### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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